Composites of zirconium carbide matrix material reinforced with carbon fibers can be fabricated relatively rapidly in a process that includes a melt infiltration step. Heretofore, these and other ceramic matrix composites have been made in a chemical vapor infiltration (CVI) process that takes months. The finished products of the CVI process are highly porous and cannot withstand temperatures above 3,000 °F (≈1,600 °C). In contrast, the melt-infiltration-based process takes only a few days, and the composite products are more nearly fully dense and have withstood temperatures as high as 4,550 °F (=2,400 °C) in a highly oxidizing thrust chamber environment. Moreover, because the melt-infiltration-based process takes much less time, the finished products are expected to cost much less.

Coating Thermoelectric Devices To Suppress Sublimation

Thermoelectric materials are covered with adherent, chemically stable metal outer layers.

A technique for suppressing sublimation of key elements from skutterudite compounds in advanced thermoelectric devices has been demonstrated. The essence of the technique is to cover what would otherwise be the exposed skutterudite surface of such a device with a thin, continuous film of a chemically and physically compatible metal. Although similar to other sublimation-suppression techniques, this technique has been specifically tailored for application to skutterudite antimonides.

The primary cause of deterioration of most thermoelectric materials is thermal decomposition or sublimation—one or more elements sublime from the hot side of a thermoelectric couple, changing the stoichiometry of the device. Examples of elements that sublimate from their respective thermoelectric materials are Ge from SiGe, Te from Pb/Te, and now Sb from skutterudite antimonides. The skutterudite antimonides of primary interest are CoSb₃ (electron-donor (n) type) and CeFe₃₋₀.₅CoSb₃ (electron-acceptor (p) type). When these compounds are subjected to typical operating conditions [temperature of 700 °C and pressure <10⁻⁵ torr (0.0013 Pa)], Sb sublimes from their surfaces, with the result that Sb depletion layers form and advance toward their interiors. As the depletion layer advances in a given device, the change in stoichiometry diminishes the thermal-to-electric conversion efficiency of the device.

The problem, then, is to prevent sublimation, or at least reduce it to an acceptably low level. In preparation for an experiment on suppression of sublimation, a specimen of CoSb₃ was tightly wrapped in a foil of niobium, which was selected for its chemical stability. In the experiment, the wrapped specimen was heated to a temperature of 700 °C in a vacuum of residual pressure <10⁻⁵ torr (0.0013 Pa), then cooled and sectioned. Examination of the sectioned specimen revealed that no depletion layer had formed, indicating the niobium foil prevented sublimation of antimony at 700 °C. This was a considerable improvement, considering that uncoated CoSb₃ had been found to decompose to form the lowest antimonide at the surface at only 600 °C. Evidently, because the mean free path of Sb at the given temperature and pressure was of the order of tens of centimeters, any barrier closer than tens of centimeters (as was the niobium foil) would have suppressed transport of Sb vapor, thereby suppressing sublimation of Sb.

The next step is melt infiltration. The preform is exposed to molten zirconium, which wicks into the preform, drawn by capillary action. The molten metal fills most of the interstices of the preform and reacts with the added carbon to form the zirconium carbide matrix material. The zirconium does not react with the underlying fibers because they are protected by the interfacial material(s). The success of the melt-infiltration step depends on interfacial material selection and uniform coating of the fibers, infiltration with the correct amount of carbon, and careful control of temperature and rate of heating. This work was done by Brian E. Williams and Robert E. Benander of Ultramet for Marshall Space Flight Center. Further information is contained in a TSP (see page 1).
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